

Search Notes

Application/Control No.

10/057,776

Examiner

Young J. Kim

Applicant(s)/Patent under
Reexamination

BERLIN, KURT

Art Unit

1637

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) see enclosed for text-search strategy | 11/21/2005 | YJK |
| Primer search on Registry file via STN Database: SEQ ID NO: 1. See enclosed strategy | 11/18/2005 | YJK |
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